

# N-Channel 650 V (D-S) Super Junction MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V) at T <sub>J</sub> max.	650				
R <sub>DS(on)</sub> (Ω) at 25 °C	$V_{GS} = 10 V$	0.19			
Q <sub>g</sub> max. (nC)	106				
Q <sub>gs</sub> (nC)	14				
Q <sub>gd</sub> (nC)	33				
Configuration	Single				

### **FEATURES**

- Reduced t<sub>rr</sub>, Q<sub>rr</sub>, and I<sub>RRM</sub>
- Low figure-of-merit (FOM) Ron x Qg
- Low input capacitance (Ciss)
- Low switching losses due to reduced Q<sub>rr</sub>
- Ultra low gate charge (Q<sub>a</sub>)
- Avalanche energy rated (UIS)

#### **APPLICATIONS**

- Telecommunications
- Server and telecom power supplies
- Lighting
  - High-intensity discharge (HID)
  - Fluorescent ballast lighting
- Consumer and computing - ATX power supplies
- Industrial
  - Welding
  - Battery chargers
- Renewable energy
- Solar (PV inverters)
- Switch mode power supplies (SMPS)

<b>ABSOLUTE MAXIMUM RATINGS</b> ( $T_c = 25 \text{ °C}$ , unless otherwise noted)									
PARAMETER	SYMBOL	LIMIT	UNIT						
Drain-Source Voltage		V <sub>DS</sub>	650	V					
Gate-Source Voltage	V <sub>GS</sub>	± 30	v						
Continuous Drain Current (T <sub>J</sub> = 150 °C)	$V_{GS} \text{ at 10 V} \frac{T_C = 25 \text{ °C}}{T_C = 100 \text{ °C}}$		20						
	$T_{\rm C} = 100 ^{\circ}{\rm C}$		13	А					
Pulsed Drain Current <sup>a</sup>	I <sub>DM</sub>	60	1						
Linear Derating Factor		1.7	W/°C						
Single Pulse Avalanche Energy <sup>b</sup>	E <sub>AS</sub>	367	mJ						
Maximum Power Dissipation	PD	208	W						
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C					
Drain-Source Voltage Slope	T <sub>J</sub> = 125 °C	-1) / / -14	37						
Reverse Diode dV/dt <sup>d</sup>		dV/dt	31	V/ns					
Soldering Recommendations (Peak Temperature) <sup>c</sup>	for 10 s		300	°C					

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature. b.  $V_{DD} = 50$  V, starting T<sub>J</sub> = 25 °C, L = 28.2 mH, R<sub>g</sub> = 25  $\Omega$ , I<sub>AS</sub> = 5.1 A.

S N-Channel MOSFET

c. 1.6 mm from case.

d.  $I_{SD} \leq I_D$ , dl/dt = 100 A/µs, starting  $T_J$  = 25 °C.







THERMAL RESISTANCE RAT	INGS							
PARAMETER	SYMBOL	TYP.		MAX.			UNIT	
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-		62				
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	- 0.5			°C/W		
		<u>.</u>						
<b>SPECIFICATIONS</b> (T <sub>J</sub> = 25 $^{\circ}$ C, u	unless otherw	ise noted)						
PARAMETER	SYMBOL	1	T CONDIT	IONS	MIN.	TYP.	MAX.	UNIT
Static	<b>I</b>				1			
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub>	= 0 V, I <sub>D</sub> =	250 µA	650	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C,	I <sub>D</sub> = 1 mA	-	0.67	-	V/°C
Gate-Source Threshold Voltage (N)	V <sub>GS(th)</sub>	V <sub>DS</sub> =	= V <sub>GS</sub> , I <sub>D</sub> =	250 µA	2	-	4	V
			$V_{GS} = \pm 20 V$ $V_{GS} = \pm 30 V$		-	-	± 100	nA
Gate-Source Leakage	I <sub>GSS</sub>				-	-	± 1	μA
Zero Gate Voltage Drain Current		V <sub>DS</sub> =	= 520 V, V <sub>G</sub>	<sub>iS</sub> = 0 V	-	-	1	
	I <sub>DSS</sub>	V <sub>DS</sub> = 520 \	V, V <sub>GS</sub> = 0 V	/, T <sub>J</sub> = 125 °C	-	-	500	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	$V_{GS} = 10 V$		<sub>D</sub> = 11 A	-	0.19	-	Ω
Forward Transconductance		V <sub>DS</sub>	= 30 V, I <sub>D</sub>	= 11 A	-	7.0	-	S
Dynamic	•	-			•	•	•	•
Input Capacitance	C <sub>iss</sub>		V <sub>GS</sub> = 0 V	,	-	2322	-	
Output Capacitance	C <sub>oss</sub>		$V_{DS} = 100 V,$ f = 1 MHz		-	105	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>				-	4	-	
Effective Output Capacitance, Energy Related <sup>a</sup>	C <sub>o(er)</sub>		$V_{DS}$ = 0 V to 520 V, $V_{GS}$ = 0 V		-	84	-	
Effective Output Capacitance, Time Related <sup>b</sup>	C <sub>o(tr)</sub>	$V_{\rm DS} = 0.0$			-	293	-	
Total Gate Charge	Qg		$V_{GS} = 10 \text{ V}$ $I_D = 11 \text{ A}, \text{ V}_{DS} = 520 \text{ V}$		-	71	106	nC
Gate-Source Charge	Q <sub>gs</sub>	$V_{GS} = 10 V$			-	14	-	
Gate-Drain Charge	Q <sub>gd</sub>				-	33	-	
Turn-On Delay Time	t <sub>d(on)</sub>		$V_{DD}$ = 520 V, I <sub>D</sub> = 11 A, V <sub>GS</sub> = 10 V, R <sub>g</sub> = 9.1 $\Omega$		-	22	44	- ns
Rise Time	t <sub>r</sub>	V <sub>DD</sub> =			-	34	68	
Turn-Off Delay Time	t <sub>d(off)</sub>	V <sub>GS</sub> :			-	68	102	
Fall Time	t <sub>f</sub>			-	42	84	]	
Gate Input Resistance	R <sub>g</sub>	f = 1 MHz, open drain		-	0.78	-	Ω	
Drain-Source Body Diode Characteristi	cs							
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET sym showing the	MOSFET symbol showing the		-	-	21	
Pulsed Diode Forward Current	I <sub>SM</sub>	integral reverse p - n junction diode		-	-	53	A	
Diode Forward Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 11 A, V <sub>GS</sub> = 0 V		-	0.9	1.2	V
Reverse Recovery Time	t <sub>rr</sub>				-	160	-	ns
Reverse Recovery Charge	Q <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = I <sub>S</sub> = 11 A, dI/dt = 100 A/μs, V <sub>R</sub> = 25 V		-	1.2	-	μC	
Reverse Recovery Current	I <sub>RRM</sub>			-	14		A	

#### Notes

a.  $C_{oss(er)}$  is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ . b.  $C_{oss(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ .



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

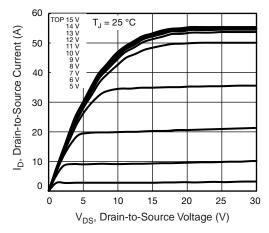


Fig. 1 - Typical Output Characteristics

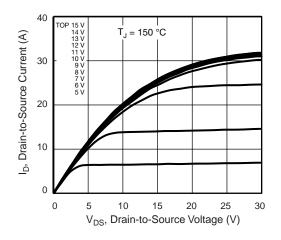


Fig. 2 - Typical Output Characteristics

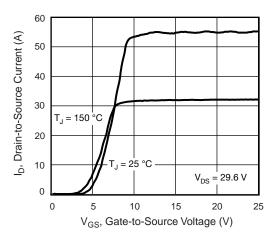


Fig. 3 - Typical Transfer Characteristics

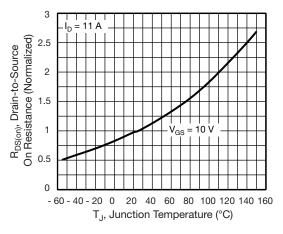


Fig. 4 - Normalized On-Resistance vs. Temperature

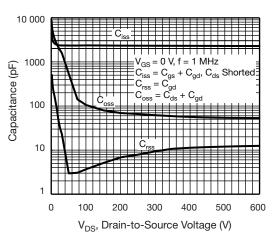


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

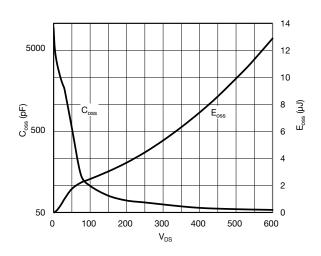


Fig. 6 -  $C_{oss}$  and  $E_{oss}$  vs.  $V_{DS}$ 

### VBZL20N65S



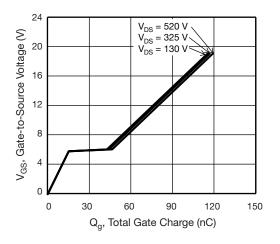


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

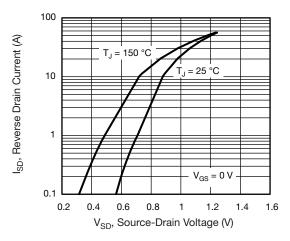


Fig. 8 - Typical Source-Drain Diode Forward Voltage

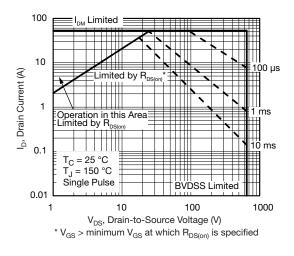


Fig. 9 - Maximum Safe Operating Area

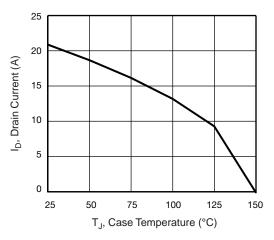


Fig. 10 - Maximum Drain Current vs. Case Temperature



Fig. 11 - Temperature vs. Drain-to-Source Voltage



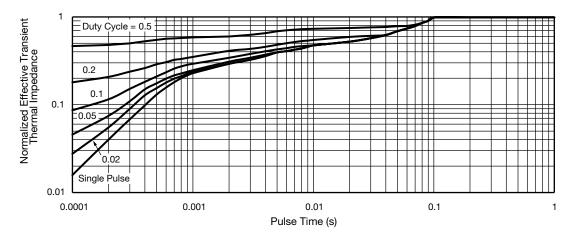


Fig. 12 - Normalized Thermal Transient Impedance, Junction-to-Case

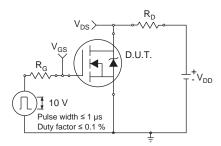


Fig. 13 - Switching Time Test Circuit

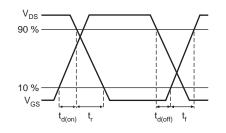


Fig. 14 - Switching Time Waveforms

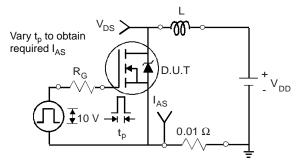


Fig. 15 - Unclamped Inductive Test Circuit

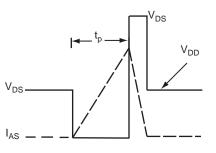


Fig. 16 - Unclamped Inductive Waveforms

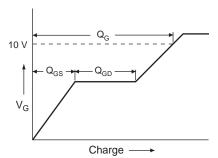
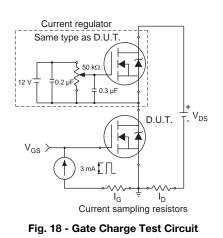
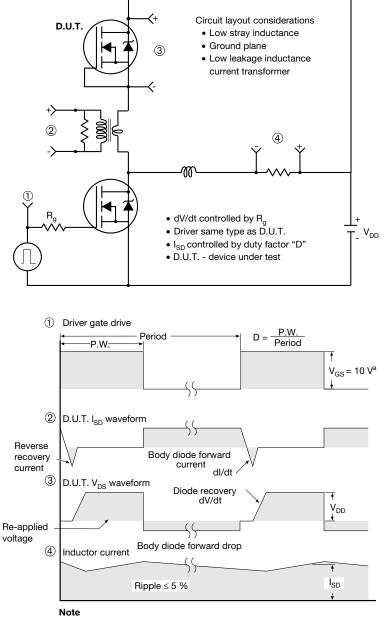


Fig. 17 - Basic Gate Charge Waveform





### Peak Diode Recovery dV/dt Test Circuit

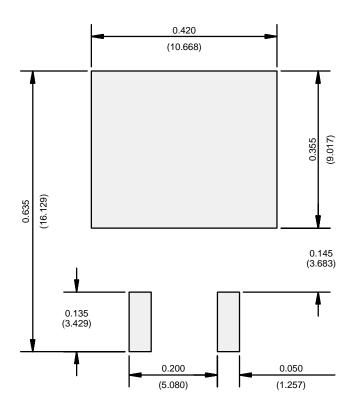


a.  $V_{GS} = 5$  V for logic level devices

Fig. 19 - For N-Channel



### **RECOMMENDED MINIMUM PADS FOR D<sup>2</sup>PAK: 3-Lead**



Recommended Minimum Pads Dimensions in Inches/(mm)



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